



## FAMILY OF MICROPOWER RAIL-TO-RAIL INPUT AND OUTPUT OPERATIONAL AMPLIFIERS

## FEATURES

- BiMOS Rail-to-Rail Input/Output
- Input Bias Current . . . 1 pA
- High Wide Bandwidth . . . 160 kHz
- High Slew Rate . . . 0.1 V/μs
- Supply Current . . . 7 µA (per channel)
- Input Noise Voltage . . . 90 nV/\Hz
- Supply Voltage Range . . . 2.7 V to 16 V
- Specified Temperature Range

   –40°C to 125°C . . . Industrial Grade
- Ultra-Small Packaging
   5 Pin SOT-23 (TLV2381)

## **APPLICATIONS**

- Portable Medical
- Power Monitoring
- Low Power Security Detection Systems
- Smoke Detectors

## DESCRIPTION

The TLV238x single supply operational amplifiers provide rail-to-rail input and output capability. The TLV238x takes the minimum operating supply voltage down to 2.7 V over the extended industrial temperature range, while adding the rail-to-rail output swing feature. The TLV238x also provides 160-kHz bandwidth from only 7  $\mu$ A. The maximum recommended supply voltage is 16 V, which allows the devices to be operated from (±8 V supplies down to ±1.35 V) two rechargeable cells.

The combination of rail-to-rail inputs and outputs make them good upgrades for the TLC27Lx family—offering more bandwidth at a lower quiescent current. The offset voltage is lower than the TLC27LxA variant.

To maintain cost effectiveness the TLV2381/2 are only available in the extended industrial temperature range. This means that one device can be used in a wide range of applications that include PDAs as well as automotive sensor interface.

All members are available in SOIC, with the singles in the small SOT-23 package, duals in the MSOP.

DEVICE	V <sub>S</sub> [V]	l <mark>q/ch</mark> [μA]	V <sub>ICR</sub> [V]	V <sub>IO</sub> [mV]	l <sub>IB</sub> [pA]	GBW [MHz]	SLEW RATE [V/µs]	V <sub>n</sub> , 1 kHz [nV/√Hz]
TLV238x	2.7 to 16	10	-0.2 to V <sub>S</sub> + 0.2	4.5	60	0.16	0.06	100
TLV27Lx	2.7 to 16	11	–0.2 to V $_{ m S}$ – 1.2	5	60	0.16	0.06	100
TLC27Lx	4 to 16	17	–0.2 to V $_{ m S}$ – 1.5	10/5/2	60	0.085	0.03	68
OPAx349	1.8 to 5.5	2	-0.2 to V <sub>S</sub> + 0.2	10	10	0.070	0.02	300
OPAx347	2.3 to 5.5	34	-0.2 to V <sub>S</sub> + 0.2	6	10	0.35	0.01	60
TLC225x	2.7 to 16	62.5	0 to V <sub>S</sub> – 1.5	1.5/0.85	60	0.200	0.02	19

SELECTION GUIDE

NOTE: All dc specs are maximums while ac specs are typicals.



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	PACKAGE/ORDERING INFORMATION												
PRODUCT	PACKAGE	PACKAGE CODE	SYMBOL	SPECIFIED TEMPERATURE RANGE	ORDER NUMBER	TRANSPORT MEDIA							
TLV2381ID	SOIC-8	D	23811		TLV2381ID	Tube							
TLV23611D	3010-0	U	23011		TLV2381IDR	Tape and Reel							
TLV2381IDBV	SOT-23	DBV	VBKI	–40°C to 125°C	TLV2381IDBVR	Tape and Reel							
TLV230TIDBV	301-23	DBV	VDRI	-40 C 10 125 C	TLV2381IDBVT	Tape and Reel							
TLV2382ID	SOIC-8	D	23821		TLV2382ID	Tube							
127230210	3010-0	U	23021		TLV2382IDR	Tape and Reel							

#### absolute maximum ratings over operating free-air temperature (unless otherwise noted)<sup>†</sup>

Supply voltage, V <sub>S</sub> Input voltage, V <sub>I</sub> (see Notes 1 and 2) Output current, I <sub>O</sub>	V <sub>S</sub> + 0.2 V
Differential input voltage, V <sub>ID</sub>	
Continuous total power dissipation	
Maximum junction temperature, T <sub>J</sub>	150°C
Operating free-air temperature range, T <sub>A</sub> : I suffix	–40°C to 125°C
Storage temperature range, T <sub>stg</sub>	–65°C to 125°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	

<sup>+</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. Relative to GND pin.

2. Maximum is 16.5 V or VS+0.2 V whichever is the lesser value.

#### T<sub>A</sub> = 85°C POWER RATING $T_A \le 25^{\circ}C$ PACKAGE $\theta$ JC $\theta_{\mathsf{JA}}$ POWER RATING (°C/W) (°C/W) D (8) 38.3 176 710 mW 370 mW DBV (5) 55 324.1 385 mW 201 mW DBV (6) 55 294.3 425 mW 221 mW

#### DISSIPATION RATING TABLE

## recommended operating conditions

		MIN	MAX	UNIT
	Dual supply	±1.35	±8	V
Supply voltage, (V <sub>S</sub> )	Single supply	2.7	16	V
Input common-mode voltage range		-0.2	V <sub>S</sub> +0.2	V
Operating free air temperature, T <sub>A</sub>	I-suffix	-40	125	°C

## electrical characteristics at recommended operating conditions, $V_S = 2.7 V$ , 5 V, and 15 V (unless otherwise noted)

#### dc performance

	PARAMETER	TEST CONDIT	IONS	T <sub>A</sub> †	MIN	TYP	MAX	UNIT
Vie	Input offset voltage			25°C		0.5	4.5	mV
VIO	input onset voltage	$V_{IC} = V_S/2, \qquad V_O = R_L = 100 \text{ k}\Omega \qquad R_S =$	VS/2 50.0	Full range			6.5	IIIV
αΛΙΟ	Offset voltage drift			25°C		1.1		μV/°C
		$V_{IC} = 0 V \text{ to } V_S,$		25°C	54	69		
		R <sub>S</sub> = 50 Ω	V <sub>S</sub> = 2.7 V	Full range	53			dB
		$V_{IC} = 0 V \text{ to } V_{S} - 1.3 V,$	VS = 2.7 V	25°C	71	86		uВ
		R <sub>S</sub> = 50 Ω		Full range	70			
		$V_{IC} = 0 V \text{ to } V_{S},$		25°C	58	74		dB
CMRR	Common-mode rejection ratio	$R_{S} = 50 \Omega$	$V_{S} = 5 V$	Full range	57			
CIVIRR	Common-mode rejection ratio	$V_{IC} = 0 V \text{ to } V_{S} - 1.3 V,$	$\nabla S = 5 \nabla$	25°C	72	88		
		R <sub>S</sub> = 50 Ω		Full range	70			
		$V_{IC} = 0 V \text{ to } V_S,$	V <sub>S</sub> = 15 V	25°C	65	80		
		$R_{S} = 50 \Omega$		Full range	64			
		$V_{IC} = 0 V \text{ to } V_{S} - 1.3 V,$		25°C	72	90		
		R <sub>S</sub> = 50 Ω		Full range	70			
			V <sub>S</sub> = 2.7 V	25°C	80	100		
			VS = 2.7 V	Full range	77			
A	Large-signal differential voltage	$V_{O(PP)}=V_S/2,$	$V_S = 5 V$	25°C	80	100		dB
AVD	amplification	$VO(PP)=VS^{/2},$ R <sub>L</sub> = 100 kΩ	vS = 3 v	Full range	77			
				25°C	77	83		
			V <sub>S</sub> = 15 V	Full range	74			

<sup>†</sup> Full range is –40°C to 125°C.

#### input characteristics

	PARAMETER	TEST (	TEST CONDITIONS		MIN	TYP	MAX	UNIT
				≤25°C		1	60	
li0	Input offset current		$V_{O} = V_{S}/2,$	≤70°C			100	pА
		$V_{IC} = V_S/2$ ,		≤125°C			1000	
		$V_{IC} = V_S/2,$ $R_L = 100 \text{ k}\Omega$ ,	$R_{S} = 50 \Omega$	≤25°C		1	60	
I <sub>IB</sub>	Input bias current			≤70°C			200	pА
				≤125°C			1000	
ri(d)	Differential input resistance			25°C		1000		GΩ
CIC	Common-mode input capacitance	f = 1 kHz		25°C		8		pF



# electrical characteristics at recommended operating conditions, $V_S = 2.7 V$ , 5 V, and 15 V (unless otherwise noted) (continued)

#### power supply

	PARAMETER	TEST CONDITIONS	T <sub>A</sub> †	MIN	TYP	MAX	UNIT
IDD	Supply surrent (per shappel)		25°C		7	10	
	Supply current (per channel)	$V_{O} = V_{S}/2$	Full range			15	μA
DEDD	Dower supply rejection ratio $(A)/a/A)/a$	$V_{S} = 2.7 V$ to 16V, No load,	25°C	74	82		dB
PSRR	Power supply rejection ratio $(\Delta V_S / \Delta V_{IO})$	$V_{IC} = V_S/2 V$	Full range	70			uВ

<sup>†</sup> Full range is –40°C to 125°C for I suffix.

#### output characteristics

	PARAMETER	TEST CONDI	TEST CONDITIONS			TYP	MAX	UNIT
			V <sub>S</sub> = 2.7 V	25°C	200	160		
			$v_{\rm S} = 2.7 v$	Full range	220			
		$V_{IC} = V_S/2$ ,		25°C	120	85		
		$V_{IC} = V_S/2,$ $I_O = 100 \ \mu A$	$V_{S} = 5 V$	Full range	200			mV
	Output voltage quing from roll		V <sub>S</sub> = 15 V	25°C	120	50		
VO	Output voltage swing from rail			Full range	150			
				25°C	800	420		
		$V_{IC} = V_S/2$ ,	V <sub>S</sub> = 5 V	Full range	900			m)/
		$V_{IC} = V_S/2,$ $I_O = 500 \ \mu A$		25°C	400	200		mV
			V <sub>S</sub> = 15 V	Full range	500			
ю	Output current	$V_{O} = 0.5 V$ from rail	V <sub>S</sub> = 2.7 V	25°C		400		μA

<sup>†</sup> Full range is  $-40^{\circ}$ C to  $125^{\circ}$ C for I suffix.

### dynamic performance

	PARAMETER	TEST CONDITIONS	TA	MIN TYP MAX	UNIT	
GBP	Gain bandwidth product	$R_L$ = 100 $k\Omega$ , $\ C_L$ = 10 pF, $\ f$ = 1 kHz	25°C	160	kHz	
			25°C	0.06		
SR	Slew rate at unity gain	$V_{O(pp)} = 2 V$ , $R_L = 100 k\Omega$ , $C_L = 10 pF$	-40°C	0.05	V/µs	
			125°C	0.08		
фМ	Phase margin		25°C	62	0	
	Gain margin	$R_{L} = 100 k\Omega$ , $C_{L} = 50 pF$	25°C	6.7	dB	
	Sottling time (0.19()	$V(STEP)_{DD} = 1 V, A_V = -1, Rise$	2500	31		
t <sub>S</sub>	Settling time (0.1%)		25°C	61	μs	

#### noise/distortion performance

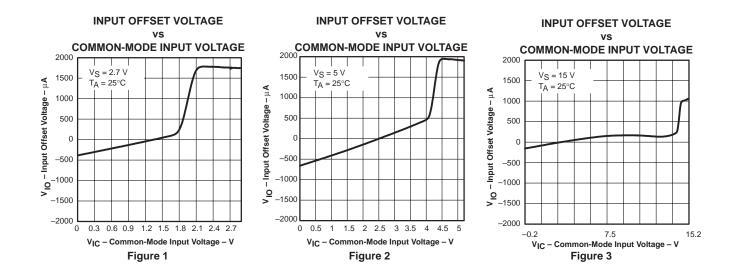
	PARAMETER	TEST CONDITIONS	Τ <sub>Α</sub>	MIN	TYP	MAX	UNIT
Vn	Equivalent input noise voltage	f = 1 kHz	25°C		90		nV/√Hz

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## **TYPICAL CHARACTERISTICS**

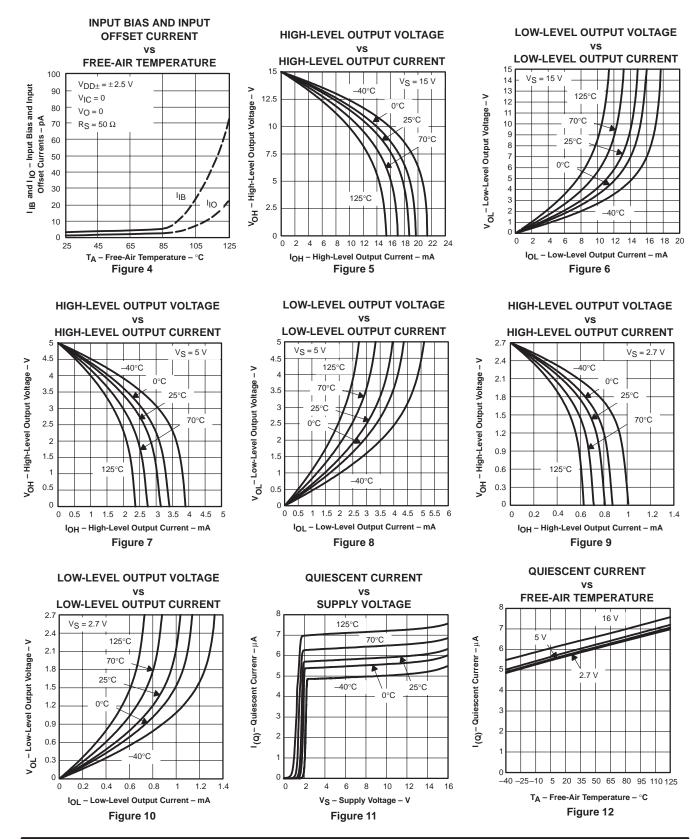
			FIGURE
VIO	Input offset voltage	vs Common-mode input voltage	1, 2, 3
IIB/IIO	Input bias and offset current	vs Free-air temperature	4
VOH	High-level output voltage	vs High-level output current	5, 7, 9
VOL	Low-level output voltage	vs Low-level output current	6, 8, 10
1.0	Quiescent current	vs Supply voltage	11
IQ	Quescent current	vs Free-air temperature	12
	Supply voltage and supply current ramp up		13
A <sub>VD</sub>	Differential voltage gain and phase shift	vs Frequency	14
GBP	Gain-bandwidth product	vs Free-air temperature	15
φm	Phase margin	vs Load capacitance	16
CMRR	Common-mode rejection ratio	vs Frequency	17
PSRR	Power supply rejection ratio	vs Frequency	18
	Input referred noise voltage	vs Frequency	19
SR	Slew rate	vs Free-air temperature	20
VO(PP)	Peak-to-peak output voltage	vs Frequency	21
	Inverting small-signal response		22
	Inverting large-signal response		23
	Crosstalk	vs Frequency	24

#### **Table of Graphs**



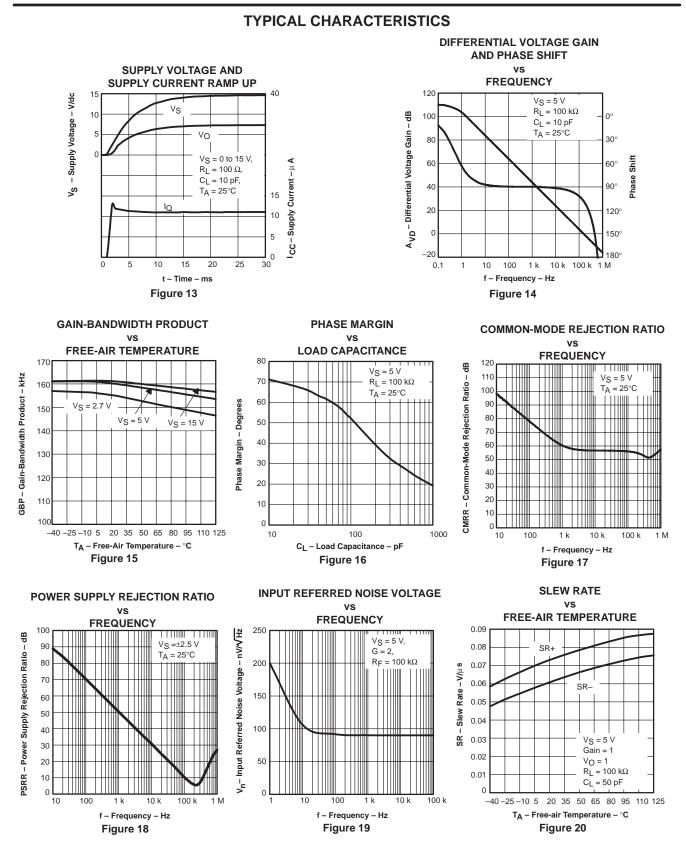


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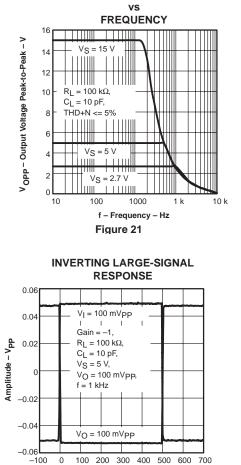
## **TYPICAL CHARACTERISTICS**

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## **TYPICAL CHARACTERISTICS**



t – Time – μs Figure 23

PEAK-TO-PEAK OUTPUT VOLTAGE

INVERTING SMALL-SIGNAL RESPONSE 2 VI = 3 VPP 1.5 Gain = -1, Amplitude – V<sub>PP</sub>  $R_L = 100 \text{ k}\Omega$ , 0.5  $C_{L} = 10 \text{ pF},$  $V_{S} = 5 \text{ V},$ 0 VO = 3 VPP, f = 1 kHz -0.5-1 -1.5 Vo = 3 Vpp \_2 -100 0 100 200 300 400 500 600 700 t – Time – μs Figure 22 CROSSTALK vs FREQUENCY 0  $V_{S} = 5 V$  $R_{L} = 2 k\Omega$  $C_{L} = 10 \text{ pF}$ -20  $T_A = 25^{\circ}C$ -40 Channel 1 to 2 -60

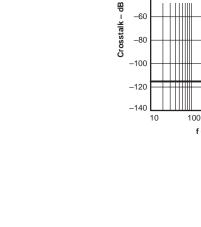
10 k

1 k

f – Frequency – Hz

Figure 24

100 k

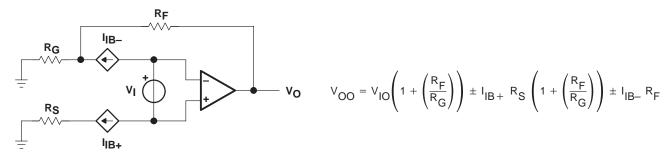




#### **APPLICATION INFORMATION**

#### offset voltage

The output offset voltage ( $V_{OO}$ ) is the sum of the input offset voltage ( $V_{IO}$ ) and both input bias currents ( $I_{IB}$ ) times the corresponding gains. The following schematic and formula can be used to calculate the output offset voltage:





#### general configurations

When receiving low-level signals, limiting the bandwidth of the incoming signals into the system is often required. The simplest way to accomplish this is to place an RC filter at the noninverting terminal of the amplifier (see Figure 26).

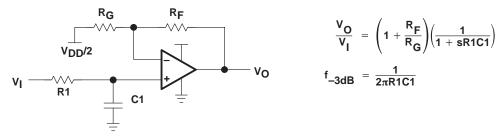


Figure 26. Single-Pole Low-Pass Filter

If even more attenuation is needed, a multiple pole filter is required. The Sallen-Key filter can be used for this task. For best results, the amplifier should have a bandwidth that is 8 to 10 times the filter frequency bandwidth. Failure to do this can result in phase shift of the amplifier.

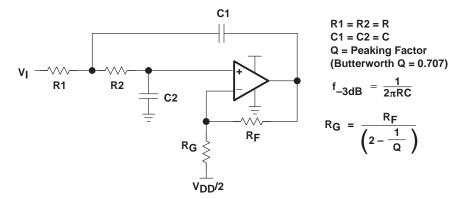


Figure 27. 2-Pole Low-Pass Sallen-Key Filter



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## APPLICATION INFORMATION

#### circuit layout considerations

TLV2381 TLV2382

To achieve the levels of high performance of the TLV238x, follow proper printed-circuit board design techniques. A general set of guidelines is given in the following.

- Ground planes—It is highly recommended that a ground plane be used on the board to provide all components with a low inductive ground connection. However, in the areas of the amplifier inputs and output, the ground plane can be removed to minimize the stray capacitance.
- Proper power supply decoupling—Use a 6.8-µF tantalum capacitor in parallel with a 0.1-µF ceramic capacitor on each supply terminal. It may be possible to share the tantalum among several amplifiers depending on the application, but a 0.1-µF ceramic capacitor should always be used on the supply terminal of every amplifier. In addition, the 0.1-µF capacitor should be placed as close as possible to the supply terminal. As this distance increases, the inductance in the connecting trace makes the capacitor less effective. The designer should strive for distances of less than 0.1 inches between the device power terminals and the ceramic capacitors.
- Sockets—Sockets can be used but are not recommended. The additional lead inductance in the socket pins will often lead to stability problems. Surface-mount packages soldered directly to the printed-circuit board is the best implementation.
- Short trace runs/compact part placements—Optimum high performance is achieved when stray series inductance has been minimized. To realize this, the circuit layout should be made as compact as possible, thereby minimizing the length of all trace runs. Particular attention should be paid to the inverting input of the amplifier. Its length should be kept as short as possible. This will help to minimize stray capacitance at the input of the amplifier.
- Surface-mount passive components—Using surface-mount passive components is recommended for high performance amplifier circuits for several reasons. First, because of the extremely low lead inductance of surface-mount components, the problem with stray series inductance is greatly reduced. Second, the small size of surface-mount components naturally leads to a more compact layout thereby minimizing both stray inductance and capacitance. If leaded components are used, it is recommended that the lead lengths be kept as short as possible.



#### **APPLICATION INFORMATION**

#### general power dissipation considerations

For a given  $\theta_{JA}$ , the maximum power dissipation is shown in Figure 28 and is calculated by the following formula:

$$\mathsf{P}_{\mathsf{D}} = \left(\frac{\mathsf{T}_{\mathsf{MAX}} - \mathsf{T}_{\mathsf{A}}}{\theta_{\mathsf{JA}}}\right)$$

Where:

P<sub>D</sub> = Maximum power dissipation of TLV238x IC (watts)

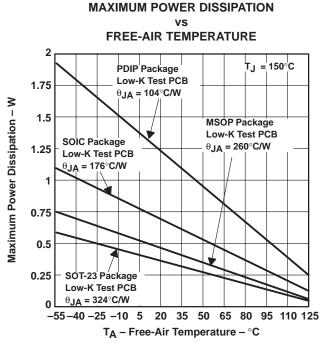
 $T_{MAX}$  = Absolute maximum junction temperature (150°C)

 $T_A$  = Free-ambient air temperature (°C)

 $\theta_{JA} = \theta_{JC} + \theta_{CA}$ 

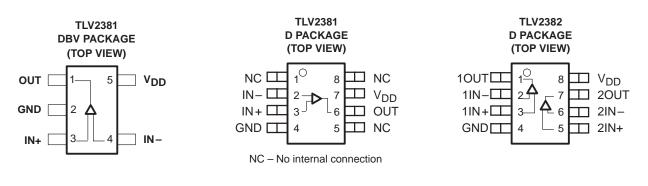
 $\theta_{JC}$  = Thermal coefficient from junction to case

 $\theta_{CA}$  = Thermal coefficient from case to ambient air (°C/W)



NOTE A: Results are with no air flow and using JEDEC Standard Low-K test PCB.

#### Figure 28. Maximum Power Dissipation vs Free-Air Temperature







### PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)			. ,	
TLV2381ID	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	23811	Samples
TLV2381IDBVR	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU   SN	Level-1-260C-UNLIM	-40 to 125	VBKI	Samples
TLV2381IDBVT	ACTIVE	SOT-23	DBV	5	250	RoHS & Green	NIPDAU   SN	Level-1-260C-UNLIM	-40 to 125	VBKI	Samples
TLV2381IDR	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	23811	Samples
TLV2382ID	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	23821	Samples
TLV2382IDG4	ACTIVE	SOIC	D	8	75	TBD	Call TI	Call TI	-40 to 125		Samples
TLV2382IDR	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	23821	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW**: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.



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## PACKAGE OPTION ADDENDUM

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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\*All dimensions are nominal

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## TAPE AND REEL INFORMATION





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TLV2381IDBVR	SOT-23	DBV	5	3000	180.0	9.0	3.15	3.2	1.4	4.0	8.0	Q3
TLV2381IDBVT	SOT-23	DBV	5	250	180.0	9.0	3.15	3.2	1.4	4.0	8.0	Q3
TLV2381IDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLV2382IDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1



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## PACKAGE MATERIALS INFORMATION

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\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TLV2381IDBVR	SOT-23	DBV	5	3000	182.0	182.0	20.0
TLV2381IDBVT	SOT-23	DBV	5	250	182.0	182.0	20.0
TLV2381IDR	SOIC	D	8	2500	353.0	353.0	32.0
TLV2382IDR	SOIC	D	8	2500	353.0	353.0	32.0

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## TUBE



## - B - Alignment groove width

\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	Τ (μm)	B (mm)
TLV2381ID	D	SOIC	8	75	507	8	3940	4.32
TLV2382ID	D	SOIC	8	75	507	8	3940	4.32

## **DBV0005A**



## **PACKAGE OUTLINE**

## SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
   This drawing is subject to change without notice.
   Reference JEDEC MO-178.

- 4. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25 mm per side.
- 5. Support pin may differ or may not be present.



## DBV0005A

## **EXAMPLE BOARD LAYOUT**

## SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



## DBV0005A

## **EXAMPLE STENCIL DESIGN**

## SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

9. Board assembly site may have different recommendations for stencil design.



## D0008A



## **PACKAGE OUTLINE**

## SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



#### NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.

- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.



## D0008A

## **EXAMPLE BOARD LAYOUT**

## SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



## D0008A

## **EXAMPLE STENCIL DESIGN**

## SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

9. Board assembly site may have different recommendations for stencil design.



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